# PWM Current-Mode Controller for Low-Power Universal Off-Line Supplies

Housed in SO–8 or DIP–8 package, the NCP1200 represents a major leap toward ultra–compact Switch–Mode Power Supplies. Thanks to a novel concept, the circuit allows the implementation of a complete offline battery charger or a standby SMPS with few external components. Furthermore, an integrated output short–circuit protection lets the designer build an extremely low–cost AC/DC wall adapter associated with a simplified feedback scheme.

With an internal structure operating at a fixed 40 kHz, 60 kHz or 100 kHz, the controller drives low gate—charge switching devices like an IGBT or a MOSFET thus requiring a very small operating power. Thanks to current—mode control, the NCP1200 drastically simplifies the design of reliable and cheap offline converters with extremely low acoustic generation and inherent pulse—by—pulse control.

When the current setpoint falls below a given value, e.g. the output power demand diminishes, the IC automatically enters the skip cycle mode and provides excellent efficiency at light loads. Because this occurs at low peak current, no acoustic noise takes place.

Finally, the IC is self-supplied from the DC rail, eliminating the need of an auxiliary winding. This feature ensures operation in presence of low output voltage or shorts.

#### **Features**

- No Auxiliary Winding Operation
- Internal Output Short-Circuit Protection
- Extremely Low No-Load Standby Power
- Current-Mode with Skip-Cycle Capability
- Internal Leading Edge Blanking
- 110 mA Peak Current Source/Sink Capability
- Internally Fixed Frequency at 40 kHz, 60 kHz and 100 kHz
- Direct Optocoupler Connection
- Built-in Frequency Jittering for Lower EMI
- SPICE Models Available for TRANsient and AC Analysis
- Internal Temperature Shutdown

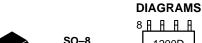
#### **Typical Applications**

- AC/DC Adapters
- Offline Battery Chargers
- Auxiliary/Ancillary Power Supplies (USB, Appliances, TVs, etc.)



## ON Semiconductor™

http://onsemi.com





SO-8 D SUFFIX CASE 751



**MARKING** 



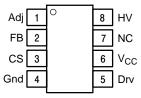
DIP-8 P SUFFIX CASE 626



A = Assembly Location

L = Wafer Lot Y, YY = Year W. WW = Work Week

## **PIN CONNECTIONS**



(Top View)

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 13 of this data sheet.

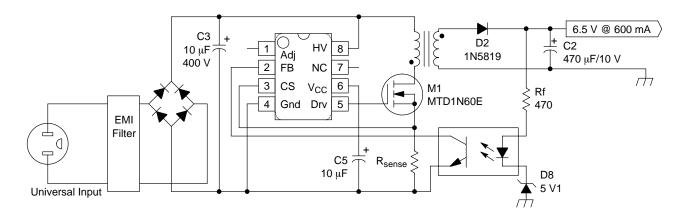
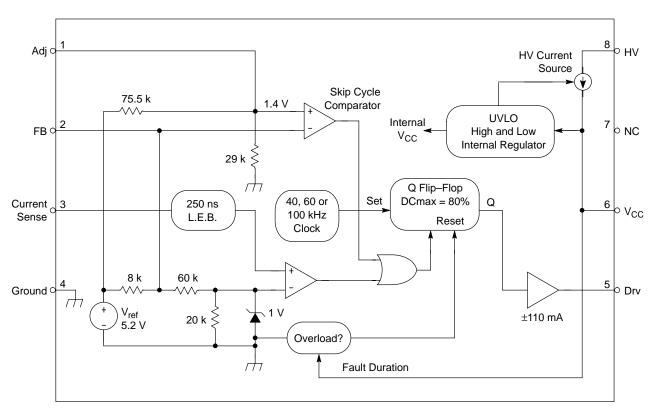


Figure 1. Typical Application

## PIN FUNCTION DESCRIPTION

Pin No.	Pin Name	Function	Description
1	Adj	Adjust the skipping peak current	This pin lets you adjust the level at which the cycle skipping process takes place
2	FB	Sets the peak current setpoint	By connecting an optocoupler to this pin, the peak current setpoint is adjusted accordingly to the output power demand
3	CS	Current sense input	This pin senses the primary current and routes it to the internal comparator via an L.E.B
4	Gnd	The IC ground	
5	Drv	Driving pulses	The driver's output to an external MOSFET
6	V <sub>CC</sub>	Supplies the IC	This pin is connected to an external bulk capacitor of typically 10 μF
7	NC	No Connection	This un-connected pin ensures adequate creepage distance
8	HV	Generates the V <sub>CC</sub> from the line	Connected to the high–voltage rail, this pin injects a constant current into the V <sub>CC</sub> bulk capacitor



**Figure 2. Internal Circuit Architecture** 

## **MAXIMUM RATINGS**

Rating	Symbol	Value	Units
Power Supply Voltage	V <sub>CC</sub>	16	V
Thermal Resistance Junction–to–Air, PDIP8 version Thermal Resistance Junction–to–Air, SOIC version	R <sub>θJA</sub> R <sub>θJA</sub>	100 178	°C/W
Maximum Junction Temperature Typical Temperature Shutdown	T <sub>Jmax</sub>	150 140	°C
Storage Temperature Range	T <sub>stg</sub>	-60 to +150	°C
ESD Capability, HBM model (All pins except V <sub>CC</sub> and HV)	_	2.0	kV
ESD Capability, Machine model	_	200	V
Maximum Voltage on pin 8 (HV), pin 6 (V <sub>CC</sub> ) grounded	-	450	V
Maximum Voltage on pin 8 (HV), pin 6 (V $_{CC}$ ) decoupled to ground with 10 $\mu F$	_	500	V

 $\textbf{ELECTRICAL CHARACTERISTICS} \text{ (For typical values } T_J = +25^{\circ}\text{C, for min/max values } T_J = -25^{\circ}\text{C to } +125^{\circ}\text{C, } \text{Max } T_J = 150^{\circ}\text{C, } \text{Max } T$ V<sub>CC</sub>= 11 V unless otherwise noted)

Rating	Pin	Symbol	Min	Тур	Max	Unit
DYNAMIC SELF-SUPPLY (All frequency versions, otherwise noted	d)					
V <sub>CC</sub> increasing level at which the current source turns-off	6	V <sub>CCOFF</sub>	10.3	11.4	12.5	V
V <sub>CC</sub> decreasing level at which the current source turns–on	6	V <sub>CCON</sub>	8.8	9.8	11	V
V <sub>CC</sub> decreasing level at which the latch–off phase ends	6	V <sub>CClatch</sub>	-	6.3	-	V
Internal IC Consumption, no output load on pin 6	6	I <sub>CC1</sub>	-	710	880 Note 1.	μА
Internal IC Consumption, 1 nF output load on pin 6, F <sub>SW</sub> = 40 kHz	6	I <sub>CC2</sub>	-	1.2	1.4 Note 2.	mA
Internal IC Consumption, 1 nF output load on pin 6, F <sub>SW</sub> = 60 kHz	6	I <sub>CC2</sub>	_	1.4	1.6 Note 2.	mA
Internal IC Consumption, 1 nF output load on pin 6, F <sub>SW</sub> = 100 kHz	6	I <sub>CC2</sub>	-	1.9	2.2 Note 2.	mA
Internal IC Consumption, latch–off phase	6	I <sub>CC3</sub>	-	350	-	μΑ
INTERNAL CURRENT SOURCE						
High–voltage current source, V <sub>CC</sub> = 10 V	8	I <sub>C1</sub>	2.8	4.0	-	mA
High-voltage current source, V <sub>CC</sub> = 0	8	I <sub>C2</sub>	-	4.9	_	mA
DRIVE OUTPUT						
Output voltage rise-time @ CL = 1 nF, 10-90% of output signal	5	T <sub>r</sub>	-	67	_	ns
Output voltage fall-time @ CL = 1 nF, 10-90% of output signal	5	T <sub>f</sub>	-	28	_	ns
Source resistance (drive = 0, Vgate = V <sub>CCHMAX</sub> - 1 V)	5	R <sub>OH</sub>	27	40	61	Ω
Sink resistance (drive = 11 V, Vgate = 1 V)	5	R <sub>OL</sub>	5	12	20	Ω
CURRENT COMPARATOR (Pin 5 un-loaded)						
Input Bias Current @ 1 V input level on pin 3	3	I <sub>IB</sub>	-	0.02	-	μΑ
Maximum internal current setpoint	3	I <sub>Limit</sub>	0.8	0.9	1.0	V
Default internal current setpoint for skip cycle operation	3	I <sub>Lskip</sub>	-	350	-	mV
Propagation delay from current detection to gate OFF state	3	T <sub>DEL</sub>	-	100	160	ns
Leading Edge Blanking Duration	3	T <sub>LEB</sub>	-	230	-	ns
<b>INTERNAL OSCILLATOR</b> ( $V_{CC}$ = 11 V, pin 5 loaded by 1 k $\Omega$ )						
Oscillation frequency, 40 kHz version	-	f <sub>OSC</sub>	36	42	48	kHz
Oscillation frequency, 60 kHz version	-	f <sub>OSC</sub>	52	61	70	kHz
Oscillation frequency, 100 kHz version	_	fosc	86	103	116	kHz
Built–in frequency jittering, F <sub>SW</sub> = 40 kHz	_	f <sub>jitter</sub>	-	300	_	Hz/V
Built–in frequency jittering, F <sub>SW</sub> = 60 kHz	-	f <sub>jitter</sub>	-	450	-	Hz/V
Built–in frequency jittering, F <sub>SW</sub> = 100 kHz	_	f <sub>jitter</sub>	-	620	-	Hz/V
Maximum duty-cycle	_	Dmax	74	80	87	%
<b>FEEDBACK SECTION</b> (Vcc = 11 V, pin 5 loaded by 1 k $\Omega$ )					1	1
Internal pull–up resistor		Rup	_	8.0	_	kΩ
Pin 3 to current setpoint division ratio		Iratio	_	4.0	_	_
SKIP CYCLE GENERATION		1		1	I	1
Default skip mode level	1	Vskip	1.1	1.4	1.6	V
Pin 1 internal output impedance	1	Zout	_	25	_	kΩ
1 May value @ T. = _25°C		1		<u>I</u>	1	1

Max value @ T<sub>J</sub> = -25°C.
 Max value @ T<sub>J</sub> = 25°C, please see characterization curves.

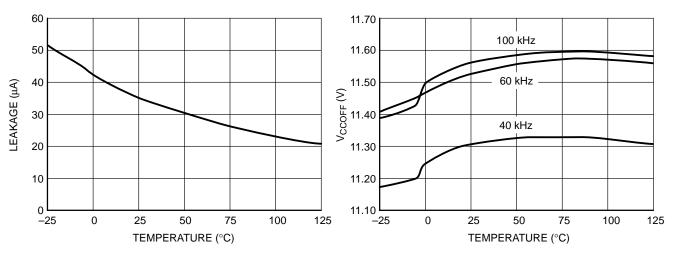


Figure 3. HV Pin Leakage Current vs. Temperature

Figure 4. V<sub>CC</sub> OFF vs. Temperature

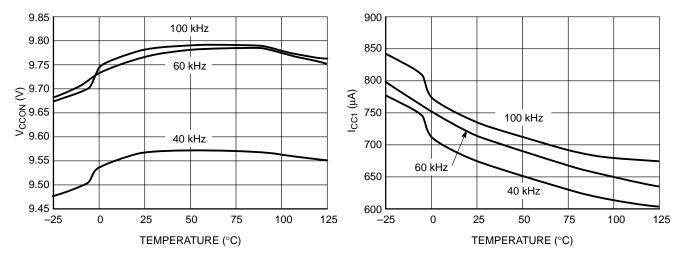


Figure 5.  $V_{CC}$  ON vs. Temperature

Figure 6. I<sub>CC1</sub> vs. Temperature

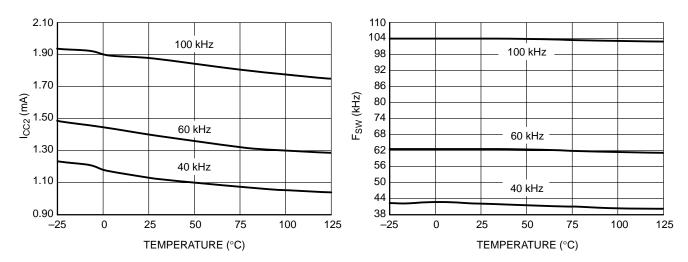
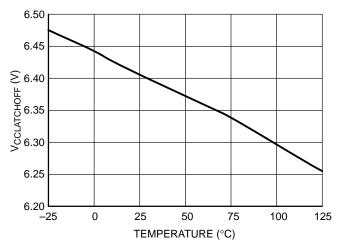


Figure 7.  $I_{CC2}$  vs. Temperature

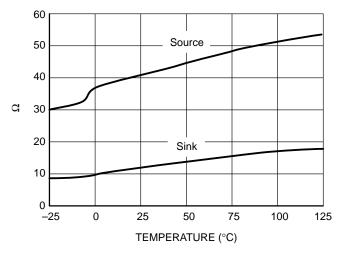
Figure 8. Switching Frequency vs. T<sub>J</sub>



460 430 400 370 (kg) 340 340 310 280 250 220 190 75 \_25 0 25 50 100 125 TEMPERATURE (°C)

Figure 9. V<sub>CC</sub> Latchoff vs. Temperature

Figure 10.  $I_{CC3}$  vs. Temperature



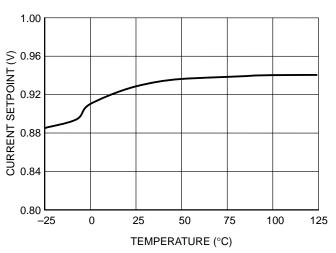
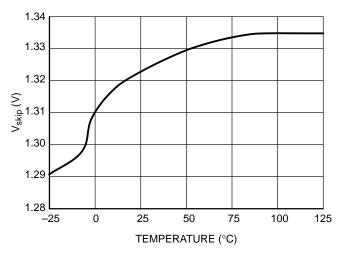


Figure 11. DRV Source/Sink Resistances

Figure 12. Current Sense Limit vs. Temperature



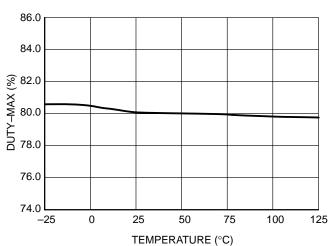


Figure 13.  $V_{\rm skip}$  vs. Temperature

Figure 14. Max Duty-Cycle vs. Temperature

#### **APPLICATIONS INFORMATION**

#### INTRODUCTION

The NCP1200 implements a standard current mode architecture where the switch–off time is dictated by the peak current setpoint. This component represents the ideal candidate where low part–count is the key parameter, particularly in low–cost AC/DC adapters, auxiliary supplies etc. Thanks to its high–performance High–Voltage technology, the NCP1200 incorporates all the necessary components normally needed in UC384X based supplies: timing components, feedback devices, low–pass filter and self–supply. This later point emphasizes the fact that ON Semiconductor's NCP1200 does NOT need an auxiliary winding to operate: the product is naturally supplied from the high–voltage rail and delivers a  $V_{\rm CC}$  to the IC. This system is called the Dynamic Self–Supply (DSS).

## **Dynamic Self-Supply**

The DSS principle is based on the charge/discharge of the  $V_{CC}$  bulk capacitor from a low level up to a higher level. We can easily describe the current source operation with a bunch of simple logical equations:

POWER–ON: IF  $V_{CC} < V_{CCOFF}$  THEN Current Source is ON, no output pulses

IF  $V_{CC}$  decreasing  $> V_{CCON}$  THEN Current Source is OFF, output is pulsing

IF  $V_{CC}$  increasing  $< V_{CCOFF}$  THEN Current Source is ON, output is pulsing

Typical values are:  $V_{CCOFF} = 11.4 \text{ V}$ ,  $V_{CCON} = 9.8 \text{ V}$ To better understand the operational principle, Figure 15's sketch offers the necessary light:

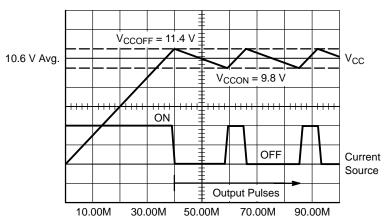


Figure 15. The Charge/Discharge Cycle Over a 10  $\mu F$  V<sub>CC</sub> Capacitor

The DSS behavior actually depends on the internal IC consumption and the MOSFET's gate charge, Qg. If we select a MOSFET like the MTD1N60E, Qg equals 11 nC (max). With a maximum switching frequency of 48 kHz (for the P40 version), the average power necessary to drive the MOSFET (excluding the driver efficiency and neglecting various voltage drops) is:

$$Fsw \cdot Qg \cdot V_{CC}$$
 with

Fsw = maximum switching frequency

Qg = MOSFET's gate charge

 $V_{CC} = V_{GS}$  level applied to the gate

To obtain the final driver contribution to the IC consumption, simply divide this result by  $V_{CC}$ : Idriver =  $\mathsf{Fsw} \cdot \mathsf{Qg} = 530~\mu\mathrm{A}$ . The total standby power consumption at no–load will therefore heavily rely on the internal IC consumption plus the above driving current (altered by the driver's efficiency). Suppose that the IC is supplied from a 400 V DC line. To fully supply the integrated circuit, let's imagine the 4 mA source is ON during 8 ms and OFF during 50 ms. The IC power contribution is therefore: 400 V . 4 mA . 0.16 = 256~mW. If for design reasons this contribution is still too high, several solutions exist to diminish it:

- 1. Use a MOSFET with lower gate charge Qg
- 2. Connect pin through a diode (1N4007 typically) to one of the mains input. The average value on pin 8 becomes  $\frac{2 * V_{mains} PEAK}{\pi}$ . Our power contribution example drops to: 160 mW.

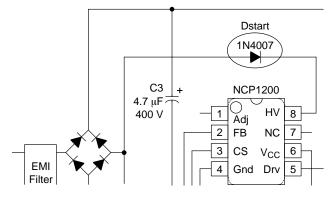


Figure 16. A simple diode naturally reduces the average voltage on pin 8

3. Permanently force the  $V_{CC}$  level above  $V_{CCH}$  with an auxiliary winding. It will automatically disconnect the internal start—up source and the IC will be fully self—supplied from this winding. Again, the total power drawn from the mains will significantly decrease. Make sure the auxiliary voltage never exceeds the 16 V limit.

### **Skipping Cycle Mode**

The NCP1200 automatically skips switching cycles when the output power demand drops below a given level. This is accomplished by monitoring the FB pin. In normal operation, pin 2 imposes a peak current accordingly to the load value. If the load demand decreases, the internal loop asks for less peak current. When this setpoint reaches a determined level, the IC prevents the current from decreasing further down and starts to blank the output pulses: the IC enters the so–called skip cycle mode, also named controlled burst operation. The power transfer now depends upon the width of the pulse bunches (Figure 18). Suppose we have the following component values:

Lp, primary inductance = 1 mH

 $F_{SW}$ , switching frequency = 48 kHz

Ip skip = 300 mA (or 350 mV / Rsense)

The theoretical power transfer is therefore:

$$\frac{1}{2} \cdot \text{Lp} \cdot \text{Ip}^2 \cdot \text{Fsw} = 2.2 \text{ W}$$

If this IC enters skip cycle mode with a bunch length of 10 ms over a recurrent period of 100 ms, then the total power transfer is:  $2.2 \cdot 0.1 = 220 \text{ mW}$ .

To better understand how this skip cycle mode takes place, a look at the operation mode versus the FB level immediately gives the necessary insight:

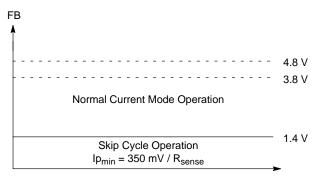


Figure 17. Feedback Voltage Variations

When FB is above the skip cycle threshold (1.4 V by default), the peak current cannot exceed 1 V/Rsense. When the IC enters the skip cycle mode, the peak current cannot go below Vpin1 / 4 (Figure 19). The user still has the flexibility to alter this 1.4 V by either shunting pin 1 to ground through a resistor or raising it through a resistor up to the desired level.

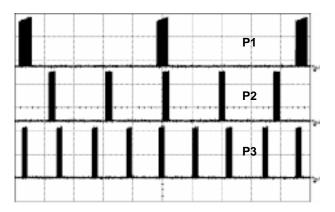


Figure 18. Output pulses at various power levels  $(X = 5 \mu s/div) P1 < P2 < P3$ 

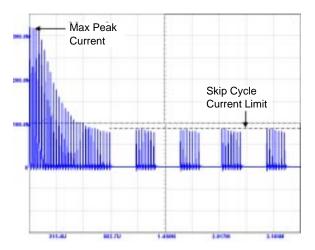


Figure 19. The skip cycle takes place at low peak currents which guarantees noise free operation

### **Power Dissipation**

The NCP1200 is directly supplied from the DC rail through the internal DSS circuitry. The current flowing through the DSS is therefore the direct image of the NCP1200 current consumption. The total power dissipation can be evaluated using:  $(V_{HVDC} - 11 V) \cdot ICC2$ . If we operate the device on a 250 VAC rail, the maximum rectified voltage can go up to 350 VDC. As a result, the worse case dissipation occurs on the 100 kHz version which will dissipate 340 . 1.8 mA@Tj = -25°C = 612 mW (however this 1.8 mA number will drop at higher operating temperatures). Α DIP8 package junction–to–ambient thermal resistance of  $R_{\theta J-A}$  100°C/W. The maximum power dissipation can thus be computed knowing the maximum operating ambient temperature (e.g. 70°C) together with the maximum allowable junction

temperature (125 °C): Pmax = 
$$\frac{T_{Jmax} - T_{Amax}}{R_{R\theta J-A}} = 550 \text{ mW}.$$

As we can see, we do not reach the worse consumption budget imposed by the 100 kHz version. Two solutions exist to cure this trouble. The first one consists in adding some copper area around the NCP1200 DIP8 footprint. By adding a min–pad area of 80 mm² of 35  $\mu$  copper (1 oz.)  $R_{\theta J-A}$  drops to about 75 °C/W which allows the use of the 100 kHz version. The other solutions are:

- 1. Add a series diode with pin 8 (as suggested in the above lines) to drop the maximum input voltage down to 222 V ((2  $\times$  350)/pi) and thus dissipate less than 400 mW
- 2. Implement a self–supply through an auxiliary winding to permanently disconnect the self–supply.

SO–8 package offers a worse  $R_{\theta J-A}$  compared to that of the DIP8 package: 178°C/W. Again, adding some copper area around the PCB footprint will help decrease this number: 12 mm x 12 mm to drop  $R_{\theta J-A}$  down to  $100^{\circ}$  C/W with 35  $\mu$  copper thickness (1 oz.) or 6.5 mm x 6.5 mm with 70  $\mu$  copper thickness (2 oz.). As one can see, we do not recommend using the SO–8 package for the 100 kHz version with DSS active as the IC may not be able to sustain the power (except if you have the adequate place on your PCB). However, using the solution of the series diode or the self–supply through the auxiliary winding does not cause any problem with this frequency version. These options are thoroughly described in the AND8023/D.

#### **Overload Operation**

In applications where the output current is purposely not controlled (e.g. wall adapters delivering raw DC level), it is interesting to implement a true short–circuit protection. A short–circuit actually forces the output voltage to be at a low level, preventing a bias current to circulate in the optocoupler LED. As a result, the FB pin level is pulled up to 4.1 V, as internally imposed by the IC. The peak current setpoint goes to the maximum and the supply delivers a rather high power with all the associated effects. Please note that this can also happen in case of feedback loss, e.g. a broken optocoupler. To account for this situation, the NCP1200 hosts a dedicated overload detection circuitry. Once activated, this circuitry imposes to deliver pulses in a burst manner with a low duty–cycle. The system recovers when the fault condition disappears.

During the start-up phase, the peak current is pushed to the maximum until the output voltage reaches its target and the feedback loop takes over. This period of time depends on normal output load conditions and the maximum peak current allowed by the system. The time-out used by this IC works with the V<sub>CC</sub> decoupling capacitor: as soon as the V<sub>CC</sub> decreases from the V<sub>CCOFF</sub> level (typically 11.4 V) the device internally watches for an overload current situation. If this condition is still present when V<sub>CCON</sub> is reached, the controller stops the driving pulses, prevents the self-supply current source to restart and puts all the circuitry in standby, consuming as little as 350 µA typical (I<sub>CC3</sub> parameter). As a result, the V<sub>CC</sub> level slowly discharges toward 0. When this level crosses 6.3 V typical, the controller enters a new startup phase by turning the current source on: V<sub>CC</sub> rises toward 11.4 V and again delivers output pulses at the UVLO<sub>H</sub> crossing point. If the fault condition has been removed before UVLO<sub>L</sub> approaches, then the IC continues its normal operation. Otherwise, a new fault cycle takes place. Figure 20 shows the evolution of the signals in presence of a fault.

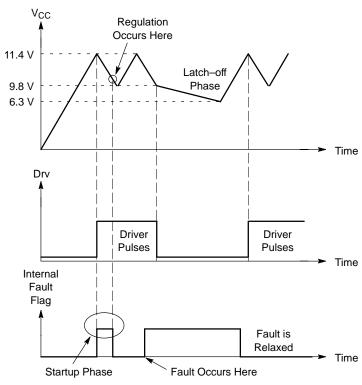


Figure 20. If the fault is relaxed during the  $V_{CC}$  natural fall down sequence, the IC automatically resumes. If the fault persists when  $V_{CC}$  reached UVLO<sub>L</sub>, then the controller cuts everything off until recovery.

## Calculating the V<sub>CC</sub> Capacitor

As the above section describes, the fall down sequence depends upon the V<sub>CC</sub> level: how long does it take for the V<sub>CC</sub> line to go from 11.4 V to 9.8 V? The required time depends on the start-up sequence of your system, i.e. when you first apply the power to the IC. The corresponding transient fault duration due to the output capacitor charging must be less than the time needed to discharge from 11.4 V to 9.8 V, otherwise the supply will not properly start. The test consists in either simulating or measuring in the lab how much time the system takes to reach the regulation at full load. Let's suppose that this time corresponds to 6ms. Therefore a V<sub>CC</sub> fall time of 10 ms could be well appropriated in order to not trigger the overload detection circuitry. If the corresponding IC consumption, including the MOSFET drive, establishes at 1.5 mA, we can calculate the required capacitor using the following formula:  $\Delta t = \frac{\Delta V \cdot C}{i},$  with  $\Delta V$  = 2V. Then for a wanted  $\Delta t$  of 10 ms,

C equals 8  $\mu F$  or 10  $\mu F$  for a standard value. When an overload condition occurs, the IC blocks its internal circuitry and its consumption drops to 350  $\mu A$  typical. This appends at  $V_{CC}=9.8$  V and it remains stuck until  $V_{CC}$  reaches 6.5 V: we are in latch–off phase. Again, using the calculated 10  $\mu F$  and 350  $\mu A$  current consumption, this latch–off phase lasts: 109 ms.

## **A Typical Application**

Figure 21 depicts a low–cost 3.5 W AC/DC 6.5 V wall adapter. This is a typical application where the wall–pack must deliver a raw DC level to a given internally regulated apparatus: toys, calculators, CD–players etc. Thanks to the inherent short–circuit protection of the NCP1200, you only need a bunch of components around the IC, keeping the final cost at an extremely low level. The transformer is available from different suppliers as detailed on the following page.

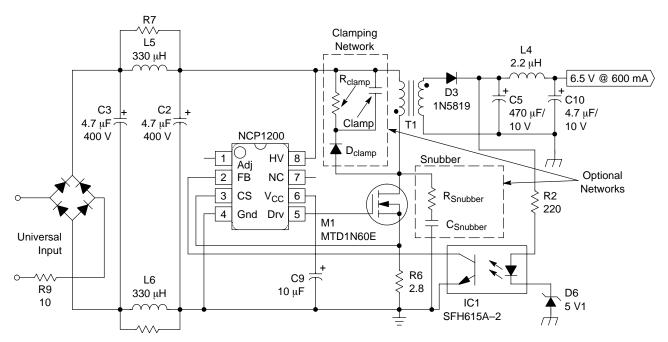


Figure 21. A typical AC/DC wall adapter showing the reduced part count thanks to the NCP1200

T1: Lp = 2.9 mH, Np:Ns = 1:0.08,  $leakage = 80 \mu\text{H}$ , E16 core, NCP1200P40

To help designers during the design stage, several manufacturers propose ready-to-use transformers for the above application, but can also develop devices based on your particular specification:

## **Eldor Corporation Headquarter**

Via Plinio 10, 22030 Orsenigo (Como) Italia

Tel.: +39-031-636 111 Fax : +39-031-636 280 Email: eldor@eldor.it

www.eldor.it

ref. 1: 2262.0058C: 3.5 W version (Lp = 2.9 mH, Lleak = 80  $\mu$ H, E16) ref. 2: 2262.0059A: 5 W version (Lp = 1.6 mH, Lleak = 45  $\mu$ H, E16)

## **EGSTON GesmbH**

Grafenbergerstraβe 37 3730 Eggenburg

Austria

Tel.: +43 (2984) 2226–0 Fax : +43 (2984) 2226–61 Email: info@egston.com

http://www.egston.com/english/index.htm

ref. 1: F0095001: 3.5 W version

(Lp = 2.7 mH, Lleak =  $30 \mu$ H, sandwich configuration, E16)

## Atelier Special de Bobinage

125 cours Jean Jaures

38130 ECHIROLLES FRANCE

Tel.: 33 (0)4 76 23 02 24 Fax: 33 (0)4 76 22 64 89 Email: asb@wanadoo.fr

ref. 1: NCP1200–10 W–UM: 10 W for USB (Lp = 1.8 mH, 60 kHz, 1:0.1, RM8 pot core)

#### Coilcraft

1102 Silver Lake Road Cary, Illinois 60013 USA Tel: (847) 639–6400 Fax: (847) 639–1469 Email: info@coilcraft.com

http://www.coilcraft.com

ref. 1: Y8844–A: 3.5 W version (Lp = 2.9 mH, Lleak = 65  $\mu$ H, E16) ref. 2: Y8848–A: 10 W version

 $(Lp = 1.8 \text{ mH}, Lleak = 45 \mu H, 1:01, E \text{ core})$ 

## Improving the Output Drive Capability

The NCP1200 features an asymmetrical output stage used to soften the EMI signature. Figure 22 depicts the way the driver is internally made:

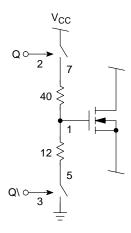


Figure 22. The higher ON resistor slows down the MOSFET while the lower OFF resistor ensures fast turn-off.

In some cases, it is possible to expand the output drive capability by adding either one or two bipolar transistors. Figures 23, 24, and 25 give solutions whether you need to improve the turn—on time only, the turn—off time or both. Rd is there to damp any overshoot resulting from long copper

traces. It can be omitted with short connections. Results showed a rise fall time improvement by 5X with standard 2N2222/2N2907:

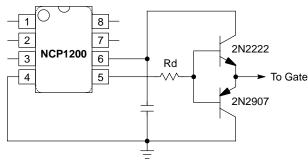


Figure 23. Improving Both Turn-On and Turn-Off Times

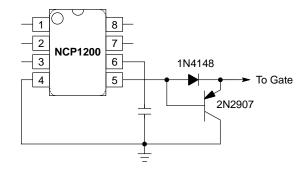


Figure 24. Improving Turn-Off Time Only

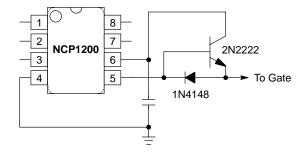


Figure 25. Improving Turn-On Time Only

If the leakage inductance is kept low, the MTD1N60E can withstand *accidental* avalanche energy, e.g. during a high–voltage spike superimposed over the mains, without the help of a clamping network. If this leakage path permanently forces a drain–source voltage above the MOSFET BVdss (600 V), a clamping network is mandatory and must be built around Rclamp and Clamp. Dclamp shall react extremely fast and can be a MUR160 type. To calculate the component values, the following formulas will help you:  $R_{clamp} =$ 

$$\frac{2 \cdot V_{\text{clamp}} \cdot (V_{\text{clamp}} - (V_{\text{out}} + Vf \text{ sec}) \cdot N)}{L_{\text{leak}} \cdot Ip^2 \cdot Fsw}$$

$$C_{clamp} = \frac{V_{clamp}}{V_{ripple} \cdot Fsw \cdot R_{clamp}}$$

with:

 $V_{clamp}$ : the desired clamping level, must be selected to be between 40 to 80 volts above the reflected output voltage when the supply is heavily loaded.

 $V_{out} + Vf$ : the regulated output voltage level + the secondary diode voltage drop

L<sub>leak</sub>: the primary leakage inductance N: the Ns:Np conversion ratio

 $\mathbf{F}_{\mathbf{SW}}$ : the switching frequency

 $V_{ripple}$ : the clamping ripple, could be around 20 V

Another option lies in implementing a snubber network which will damp the leakage oscillations but also provide more capacitance at the MOSFET's turn-off. The peak voltage at which the leakage forces the drain is calculated

by: 
$$V_{\text{max}} = Ip \cdot \sqrt{\frac{L_{\text{leak}}}{C_{\text{lump}}}}$$
 where  $C_{\text{lump}}$  represents the

total parasitic capacitance seen at the MOSFET opening. Typical values for Rsnubber and Csnubber in this 4W application could respectively be 1.5 k $\Omega$  and 47 pF. Further tweaking is nevertheless necessary to tune the dissipated power versus standby power.

#### **Available Documents**

"Implementing the NCP1200 in Low-cost AC/DC Converters", AND8023/D

"Conducted EMI Filter Design for the NCP1200", AND8032/D

"Ramp Compensation for the NCP1200", AND8029/D

TRANSient and AC models available to download at: http://onsemi.com/pub/NCP1200

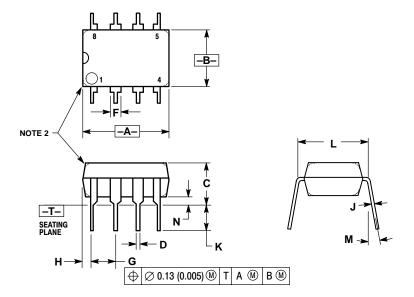
NCP1200 design spreadsheet available to download at: http://onsemi.com/pub/NCP1200

#### ORDERING INFORMATION

Device	Туре	Package	Shipping
NCP1200P40	F <sub>SW</sub> = 40 kHz	PDIP8	50 Units / Rail
NCP1200D40	F <sub>SW</sub> = 40 kHz	SO-8	2500 Units /Reel
NCP1200P60	F <sub>SW</sub> = 60 kHz	PDIP8	50 Units / Rail
NCP1200D60	F <sub>SW</sub> = 60 kHz	SO-8	2500 Units /Reel
NCP1200P100	F <sub>SW</sub> = 100 kHz	PDIP8	50 Units / Rail
NCP1200D100	F <sub>SW</sub> = 100 kHz	SO-8	2500 Units / Reel

## **PACKAGE DIMENSIONS**

DIP8 P SUFFIX CASE 626-05 ISSUE L

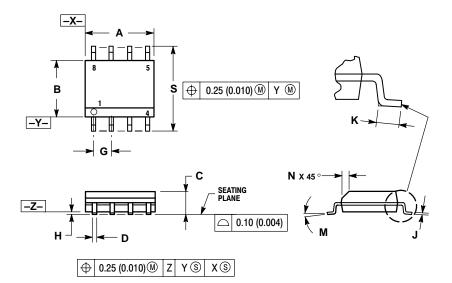


- NOTES:
  1. DIMENSION L TO CENTER OF LEAD WHEN FORMED PARALLEL.
  2. PACKAGE CONTOUR OPTIONAL (ROUND OR SQUARE CORNERS).
  3. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

	MILLIMETERS		INCHES			
DIM	MIN	MAX	MIN	MAX		
Α	9.40	10.16	0.370	0.400		
В	6.10	6.60	0.240	0.260		
С	3.94	4.45	0.155	0.175		
D	0.38	0.51	0.015	0.020		
F	1.02	1.78	0.040	0.070		
G	2.54	2.54 BSC		0.100 BSC		
Н	0.76	1.27	0.030	0.050		
J	0.20	0.30	0.008	0.012		
K	2.92	3.43	0.115	0.135		
L	7.62 BSC		0.300 BSC			
M		10°		10°		
N	0.76	1.01	0.030	0.040		

## **PACKAGE DIMENSIONS**

(SO-8) D SUFFIX CASE 751-07 ISSUE V



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
  4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- 4. MAXIMUM MOLD PROTITUGION 6.10 (6.000), 2.1.
  SIDE.
  5. DIMENSION D DOES NOT INCLUDE DAMBAR
  PROTRUSION ALLOWABLE DAMBAR
  PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN
  EXCESS OF THE D DIMENSION AT MAXIMUM
  MATERIAL CONDITION.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	4.00	0.150	0.157	
С	1.35	1.75	0.053	0.069	
D	0.33	0.51	0.013	0.020	
G	1.27 BSC		0.050 BSC		
Н	0.10	0.25	0.004	0.010	
J	0.19	0.25	0.007	0.010	
K	0.40	1.27	0.016	0.050	
M	0 °	8 °	0 °	8 °	
N	0.25	0.50	0.010	0.020	
S	5 80	6.20	0.228	0.244	

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